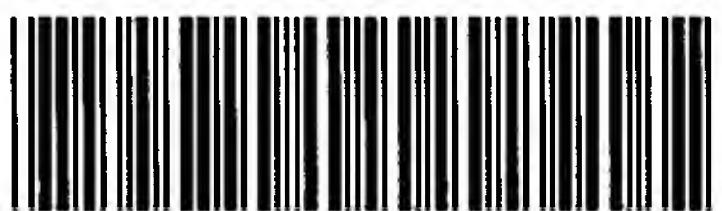


Search Notes



Application/Control No.

10/565.516

Examiner

JOHN J. LEE

**Applicant(s)/Patent under
Reexamination**

CEDRAEUS, HUGO

Art Unit

2618

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)